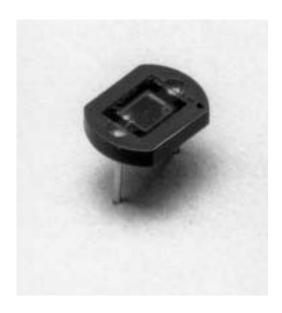
## **VTB Process Photodiodes**

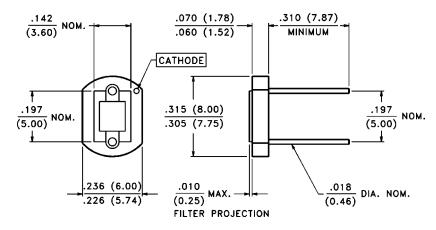
# VTB8440B, 8441B



## PRODUCT DESCRIPTION

Planar silicon photodiode in recessed ceramic package. The package incorporates an infrared rejection filter. These diodes have very high shunt resistance and have good blue response.

## PACKAGE DIMENSIONS inch (mm)



CASE 21F 8 mm CERAMIC CHIP ACTIVE AREA: .008 in<sup>2</sup> (5.16 mm<sup>2</sup>)

#### **ABSOLUTE MAXIMUM RATINGS**

Storage Temperature: -20°C to 75°C

Operating Temperature: -20°C to 75°C

#### **ELECTRO-OPTICAL CHARACTERISTICS @ 25°C**

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VTB8440B			VTB8441B			LIMITO
			Min.	Тур.	Max.	Min.	Тур.	Max.	UNITS
I <sub>SC</sub>	Short Circuit Current	H = 100 fc, 2850 K	4	5		4	5		μΑ
TC I <sub>SC</sub>	I <sub>SC</sub> Temperature Coefficient	2850 K		.02	.08		.02	.08	%/°C
V <sub>OC</sub>	Open Circuit Voltage	H = 100 fc, 2850 K		420			420		mV
TC V <sub>OC</sub>	V <sub>OC</sub> Temperature Coefficient	2850 K		-2.0			-2.0		mV/°C
I <sub>D</sub>	Dark Current	H = 0, VR = 2.0 V			2000			100	pA
R <sub>SH</sub>	Shunt Resistance	H = 0, V = 10 mV		.07			1.4		GΩ
TC R <sub>SH</sub>	R <sub>SH</sub> Temperature Coefficient	H = 0, V = 10 mV		-8.0			-8.0		%/°C
СЈ	Junction Capacitance	H = 0, V = 0		1.0			1.0		nF
$\lambda_{range}$	Spectral Application Range		330		720	330		720	nm
$\lambda_{p}$	Spectral Response - Peak			580			580		nm
$V_{BR}$	Breakdown Voltage		2	40		2	40		V
θ <sub>1/2</sub>	Angular Resp 50% Resp. Pt.			±50			±50		Degrees
NEP	Noise Equivalent Power		1.1 x 10 <sup>-13</sup> (Typ.)		2.4 x 10 <sup>-14</sup> (Typ.)			W∕√Hz	
D*	Specific Detectivity		2.2 x 10 <sup>12</sup> (Typ.)			9.7 x 10 <sup>12</sup> (Typ.)			cm√Hz/W

## **VTB Process Photodiodes**

# VTB PROCESS BLUE ENHANCED, ULTRA HIGH DARK RESISTANCE

#### **FEATURES**

- Enhanced UV to IR spectral range
- Integral IR rejection filters available
- Response @ 220 nm, 0.06 A/W, typical with UV window
- Response @ 365 nm, 0.14 A/W typical
- High open circuit voltage @ low light levels
- 1 to 2% linearity over 7 to 9 decades
- Very low dark current & high shunt resistance

#### PRODUCT DESCRIPTION

This series of P on N silicon planar photodiodes have been designed to maximize their response through the visible part of the spectrum. Those units with UV transmitting windows also exhibit excellent response in the UV region and are characterized at 220 nm.

"B" series devices have a built-in infrared rejection filter for those applications where a detector is needed that approximates the human eye. Typical transmission of wavelengths greater than 750 nm is less than 3% when measured with an incandescent source operating at 2850 K.

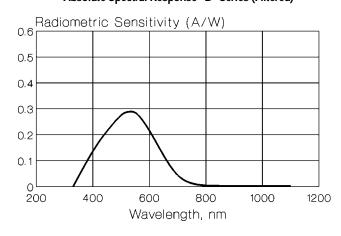
Diodes made with the VTB process are primarily intended for use in the photovoltaic mode but may be used with a small reverse bias. All photodiodes in this series exhibit very high shunt resistance. This characteristic leads to very low offsets when the diodes are used in high gain transimpedance op-amp circuits.

## TYPICAL CHARACTERISTIC CURVES @ 25°C (UNLESS OTHERWISE NOTED)

#### **Absolute Spectral Response**

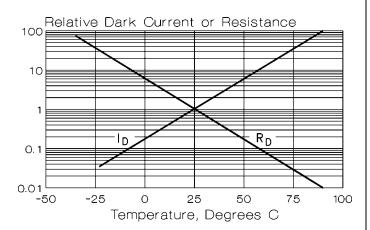
#### Radiometric Sensitivity (A/W) Q.E. = 0.750.5 0.4WITH UVT 0.3 LENS Q.E. 0.50 0.2 GLASS WINDOW OR EPOXY COATED 0 L 200 400 600 800 1000 1200 Wavelength, nm

#### Absolute Spectral Response "B" Series (Filtered)

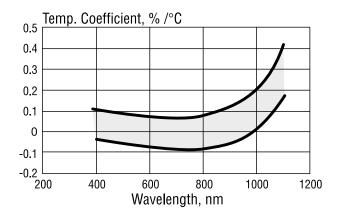


## **VTB Process Photodiodes**

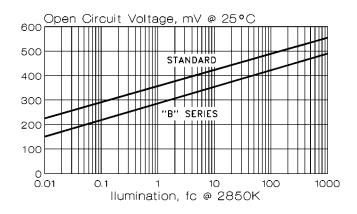
#### Relative Dark Current or Resistance vs. Temperature (Refered To 25°C)



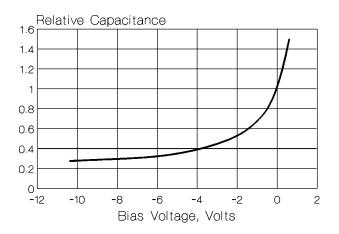
#### Temperature Coefficient of Light Current vs. Wavelength



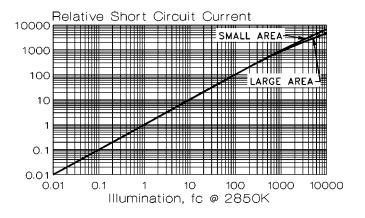
#### Open Circuit Voltage vs Illumination



#### Relative Junction Capacitance vs. Voltage (Reffered To Zero Bias)



# Relative Short Circuit Current vs. Illumination



#### Rise/fall Times - Non Standard

